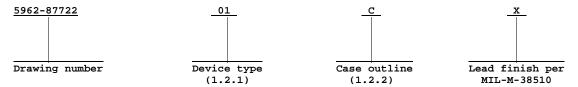
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<b>3 11/1</b>									PA	GE	1				OF	:	11		

#### 1. SCOPE

1.3

1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:



1.2.1 <u>Device type</u>. The device type shall identify the circuit function as follows:

Device type	Generic number	Circuit function
01	54HC4075	Triple 3-input OR gate

1.2.2 <u>Case outlines</u>. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Case outline

		<del></del>
С	D-1 (14-lead, 1/4" x 3/4"), dual-i	n-line package
D	F-2 (14-lead, $1/4$ " x $3/8$ "), flat p	ackage
2	C-2 (20-terminal, .350" x .350"),	square chip carrier package
3 Absolute maximum ratings.	<u>1</u> /	
Supply voltage range		-0.5 V dc to +7.0 V dc
DC input voltage		-0.5 V dc to $V_{CC}$ +0.5 V dc
DC output voltage		-0.5 V dc to V <sub>CC</sub> +0.5 V dc
		+20 ma

±25 mA ±50 mA -65°C to +150°C 500 mW

+260°C

See MIL-M-38510, appendix C +175°C

1.4 Recommended operating conditions.

Outline letter

+2.0 V dc to +6.0 V dc Case operating temperature range  $(T_C)$  - - - - - - --55°C to +125°C Input rise or fall time: 0 to 1000 ns 0 to 500 ns

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 $<sup>\</sup>frac{1}{2}$ / Unless otherwise specified, all voltages are referenced to ground.

 $<sup>\</sup>underline{2}$ / For  $T_C = +100$ °C to +125°C, derate linearly at 12 mW/°C.

#### 2. APPLICABLE DOCUMENTS

2.1 <u>Government specification and standard</u>. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510 - Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

### 3. REQUIREMENTS

- 3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
- 3.2.1 <u>Terminal connections and logic diagram</u>. The terminal connections and logic diagram shall be as specified on figure 1.
  - 3.2.2 Truth table. The truth table shall be as specified on figure 3.
  - 3.2.3 Switching waveforms. The switching waveforms shall be as specified on figure 2.
  - 3.2.4 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended case operating temperature range.
- 3.4 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

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Test	Symbol				Li	mits	Unit
		-55°C ≤ T <sub>C</sub> ≤	+125°C	subgroups	Min	Max	
High level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_0  \le 20  \mu\text{A}$	v <sub>CC</sub> = 2.0 v	1,2,3	1.9		v
			V <sub>CC</sub> = 4.5 V		4.4		
			V <sub>CC</sub> = 6.0 V		5.9		
		I <sub>O</sub>   < 4.0 mA	V <sub>CC</sub> = 4.5 V		3.7		
		I <sub>O</sub>	V <sub>CC</sub> = 6.0 V		5.2		
Low level output voltage	v <sub>OL</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_0  \le 20  \mu\text{A}$	V <sub>CC</sub> = 2.0 V	1,2,3		0.1	v
			V <sub>CC</sub> = 4.5 V			0.1	
			V <sub>CC</sub> = 6.0 V			0.1	
		I <sub>O</sub>	V <sub>CC</sub> = 4.5 V			0.4	
		I <sub>O</sub>   < 5.2 mA	V <sub>CC</sub> = 6.0 V			0.4	
High level input voltage	V <sub>IH</sub>	<u>2</u> /	V <sub>CC</sub> = 2.0 V	1,2,3	1.5		v
			V <sub>CC</sub> = 4.5 V		3.15		
			V <sub>CC</sub> = 6.0 V		4.2		
Low level input voltage	v <sub>IL</sub>	<u>2</u> /	V <sub>CC</sub> = 2.0 V	1,2,3		0.3	v
			V <sub>CC</sub> = 4.5 V			0.9	_
			<sub>VC</sub> C = 6.0 V			1.2	-
Input capacitance	C <sub>IN</sub>	V <sub>IN</sub> = 0 V; T <sub>C</sub> = +25°C see 4.3.1c		4		10	pF
		B00 110120					

See footnotes at end of table.

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TABLE I. <u>Electrical performance characteristics</u> - Continued.								
Test Symbol		Conditions	Group A	Limits		Unit		
		-55°C ≤ T <sub>C</sub> ≤ +	125°C	subgroups	Min	Max		
Quiescent current	I <sub>CC</sub>	$V_{CC}$ = 6.0 V; $V_{IN}$ = $V_{CC}$ or (	END	1,2,3		160	μΆ	
Input leakage current	IIN	$V_{CC}$ = 6.0 V; $V_{IN}$ = $V_{CC}$ or 0	END	1,2,3		±1	μА	
Functional tests		see 4.3.1d		7				
Propagation delay time A, B, or C to output	t <sub>PHL</sub>	T <sub>C</sub> = +25°C C <sub>T</sub> = 50 pF ±10%	V <sub>CC</sub> = 2.0 V	9		115	ns	
Y <u>3</u> /		_	V <sub>CC</sub> = 4.5 V			23		
			v <sub>CC</sub> = 6.0 v			20		
See figure 3		T <sub>C</sub> = -55°C, +125°C C <sub>L</sub> = 50 pF ±10%	V <sub>CC</sub> = 2.0 V	10,11		175	ns	
		_	V <sub>CC</sub> = 4.5 V			35		
			v <sub>CC</sub> = 6.0 v			30		
Transition time $\frac{4}{4}$	t <sub>THL</sub> ,	T <sub>C</sub> = +25°C C <sub>L</sub> = 50 pF ±10%	v <sub>CC</sub> = 2.0 v	9		75	ns	
			V <sub>CC</sub> = 4.5 V			15		
			v <sub>CC</sub> = 6.0 v			13		
See figure 3		T <sub>C</sub> = -55°C, +125°C C <sub>L</sub> = 50 pF ±10%	V <sub>CC</sub> = 2.0 V	10,11		110	ns	
			V <sub>CC</sub> = 4.5 V			22		
			v <sub>CC</sub> = 6.0 v			19		

See footnotes on next page.

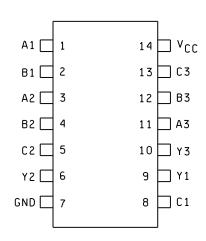
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- $\underline{1}$ / For a power supply of 5 V ±10 percent the worst case output voltage (V<sub>OH</sub> and V<sub>OL</sub>) occur for HC at 4.5 V. Thus the 4.5 V values should be used when designing with this supply. Worst case V<sub>IH</sub> and V<sub>IL</sub> occur at V<sub>CC</sub> = 5.5 V and 4.5 V respectively. (The V<sub>IH</sub> value at 5.5 V is 3.85 V). The worst case leakage current (I<sub>IN</sub>, I<sub>CC</sub>, and I<sub>QZ</sub>) occur for CMOS at the higher voltage and so the 6.0 V values should be used. Power dissipation capacitance (C<sub>PD</sub>), typically 100 pF, determines the no load dynamic power consumption, P<sub>D</sub> = C<sub>PD</sub> V<sub>CC</sub><sup>2</sup> f + I<sub>CC</sub> V<sub>CC</sub>, and the no load dynamic current consumption, I<sub>S</sub> = C<sub>PD</sub> V<sub>CC</sub> f + I<sub>CC</sub>.
- $\underline{2}/$  Test not required if applied as a forcing function for  $V_{OH}$  or  $V_{OL}$ .
- $\underline{3}/$  AC testing at  $V_{CC}$  = 2.0 V and  $V_{CC}$  = 6.0 V shall be guaranteed, if not tested, to the specified parameters.
- $\underline{4}$ / Transition time ( $t_{TLH}$ ,  $t_{THL}$ ), if not tested, shall be guaranteed to the specified parameters.
- 3.5 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 <u>Verification and revie</u>w. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
  - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
  - a. Burn-in test (method 1015 of MIL-STD-883).
    - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
    - (2)  $T_A = +125^{\circ}C$ , minimum.
  - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

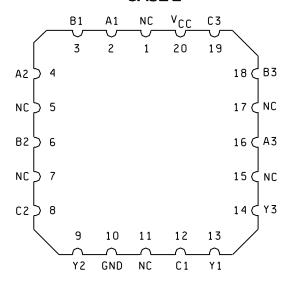
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# DEVICE TYPE 01

## CASES C AND D

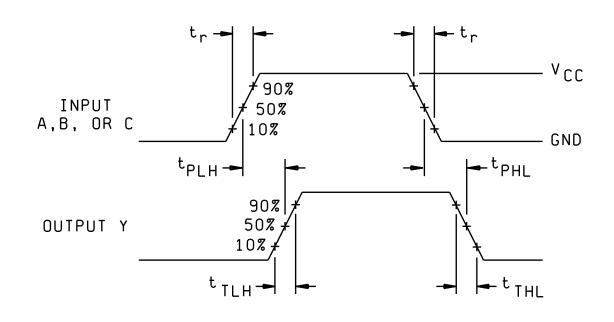


# CASE 2



### FIGURE 1. Terminal connections and logic diagram.

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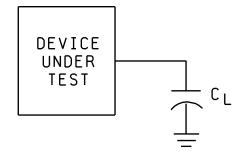


FIGURE 2. Switching time waveforms.

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Inputs		Outputs	
A	В	С	У
L	L	L	L
н	х	х	н
x	н	х	н
x	х	н	н
L H X	L X H	L X X	L H H

FIGURE 3. Truth table.

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- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
  - 4.3.1 Group A inspection.
    - a. Tests shall be as specified in table II herein.
    - b. Subgroups 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
    - c. Subgroup 4 ( $C_{\rm IN}$  measurement) shall be measured only for the initial test and after process or design changes which may affect input capacitance.
    - d. Subgroup 7 tests sufficiently to verify truth table.
  - 4.3.2 Groups C and D inspections.
    - a. End-point electrical parameters shall be as specified in table II herein.
    - b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
      - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
      - (2)  $T_A = +125^{\circ}C$ , minimum.
      - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

TABLE II. <u>Electrical test requirements</u>.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	
Final electrical test parameters (method 5004)	1*, 2, 3, 9
Group A test requirements (method 5005)	1, 2, 3, 4, 7, 9, 10, 11**
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3
Additional electrical subgroups for group C periodic inspections	

- \* PDA applies to subgroup 1.
- \*\* Subgroup 10 and 11, if not tested shall be guaranteed to the specified limits in table I.

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- 5. PACKAGING
- 5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.
- 6. NOTES
- 6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 <u>Comments</u>. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.
- 6.4 <u>Approved sources of supply</u>. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor <u>1</u> / similar part number	Replacement military specification part number
5962-8772201CX	01295 04713 27014 18714	SNJ54HC4075J 54HC4075/BCAJC MM54HC4075J/883 CD54HC4075F/3A	
5962-8772201DX	27014	MM54HC4075E/883	
5962-87722012x	01295 04713 27014	SNJ54HC4075FK 54HC4075M/B2CJC MM54HC4075W/883	

<u>1</u>/ <u>Caution</u>. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name <u>and address</u>
01295	Texas Instruments Incorporated P.O. Box 6448 Midland, TX 79711
04713	Motorola, Incorporated 7402 South Price Road Tempe, AZ 85283
27014	National Semiconductor Corporation 2900 Semiconductor Drive Santa Clara, CA 95051
18714	GE/RCA Corporation Route 202 Somerville, NJ 08876

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